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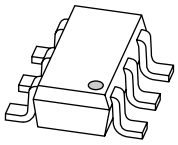


PMD2001D

MOSFET driver

Rev. 02 — 28 August 2009 Product data sheet

1. Product profile

1.1 General description

NPN/PNP transistor pair connected as push-pull driver in a SOT457 (SC-74) Surface-Mounted Device (SMD) plastic package.

1.2 Features

- Switching transistors in push-pull configuration
- Application-optimized pinout
- Space-saving solution
- Internal connections to minimize layout effort
- Reduces component count

1.3 Applications

- MOSFET driver
- Power bipolar transistor driver
- Output current booster for operational amplifier

1.4 Quick reference data

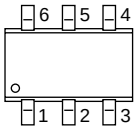
Table 1. Quick reference data

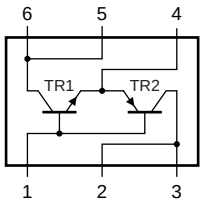
Symbol	Parameter	Conditions	Min	Typ	Max	Unit
Per transistor; for the PNP transistor with negative polarity						
V_{CEO}	collector-emitter voltage	open base	-	-	40	V
I_C	collector current		-	-	0.6	A
I_{CM}	peak collector current	single pulse; $t_p \leq 1$ ms	-	-	1	A

2. Pinning information

Table 2. Pinning

Pin	Description	Simplified outline	Symbol
1	base TR1, TR2		
2	collector TR2		
3	collector TR2		
4	emitter TR1, TR2		
5	collector TR1		
6	collector TR1		





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3. Ordering information

Table 3. Ordering information

Type number	Package		
	Name	Description	Version
PMD2001D	SC-74	plastic surface-mounted package (TSOP6); 6 leads	SOT457

4. Marking

Table 4. Marking codes

Type number	Marking code
PMD2001D	9E

5. Limiting values

Table 5. Limiting values

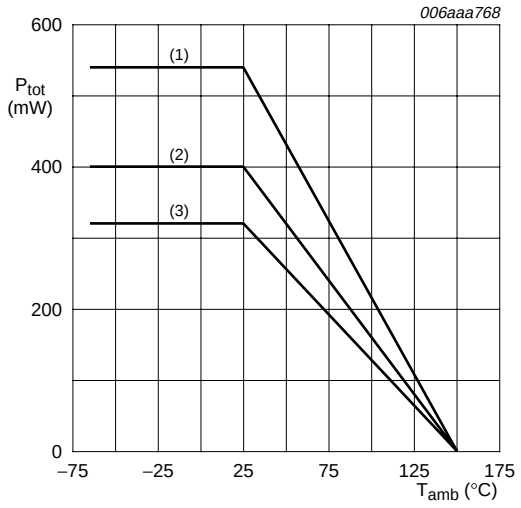
In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions		Min	Max	Unit
Per transistor; for the PNP transistor with negative polarity						
V_{CBO}	collector-base voltage	open emitter		-	40	V
V_{CEO}	collector-emitter voltage	open base		-	40	V
I_C	collector current			-	0.6	A
I_{CM}	peak collector current	single pulse; $t_p \leq 1$ ms		-	1	A
I_{BM}	peak base current			-	0.1	A
		single pulse; $t_p \leq 1$ ms		-	0.2	A
Per device						
P_{tot}	total power dissipation	$T_{amb} \leq 25$ °C	[1]	-	320	mW
			[2]	-	400	mW
			[3]	-	540	mW
T_j	junction temperature			-	150	°C
T_{amb}	ambient temperature			–65	+150	°C
T_{stg}	storage temperature			–65	+150	°C

[1] Device mounted on an FR4 Printed-Circuit Board (PCB), single-sided copper, tin-plated and standard footprint.

[2] Device mounted on an FR4 PCB, single-sided copper, tin-plated, mounting pad for collector 1cm^2.

[3] Device mounted on a ceramic PCB, Al_2O_3, standard footprint.



(1) Ceramic PCB, Al_2O_3, standard footprint

(2) FR4 PCB, mounting pad for collector 1cm^2

(3) FR4 PCB, standard footprint

Fig 1. Power derating curves

6. Thermal characteristics

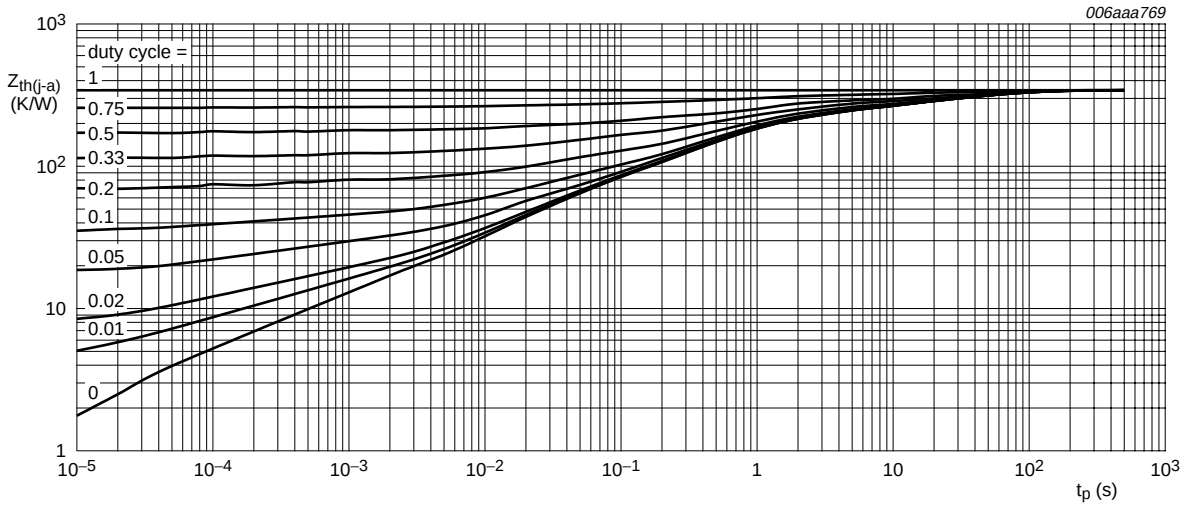
Table 6. Thermal characteristics

Symbol	Parameter	Conditions		Min	Typ	Max	Unit
$R_{th(j-a)}$	thermal resistance from junction to ambient	in free air	[1]	-	-	390	K/W
			[2]	-	-	315	K/W
			[3]	-	-	230	K/W

[1] Device mounted on an FR4 PCB, single-sided copper, tin-plated and standard footprint.

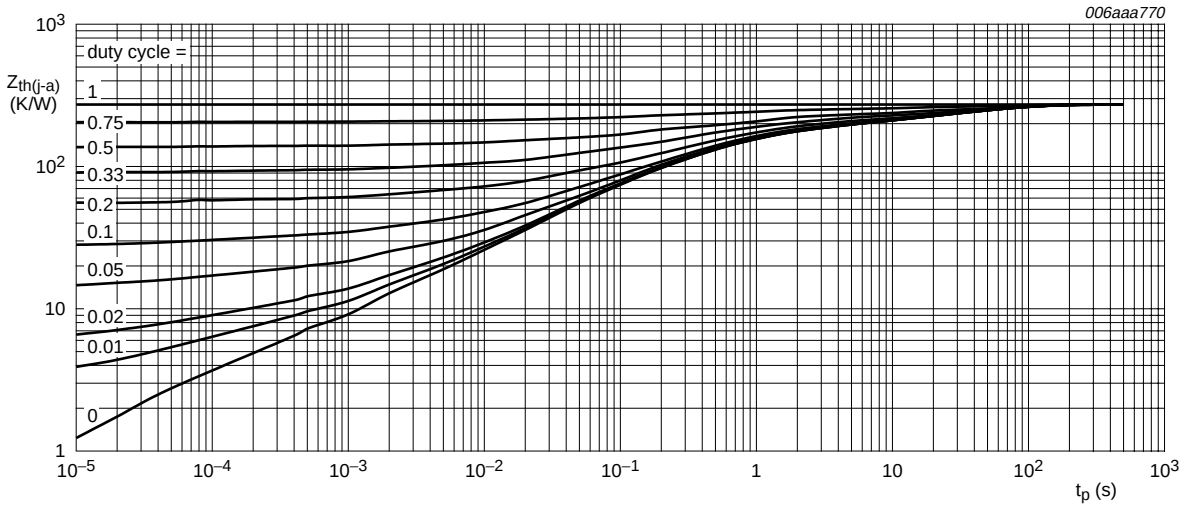
[2] Device mounted on an FR4 PCB, single-sided copper, tin-plated, mounting pad for collector 1cm^2.

[3] Device mounted on a ceramic PCB, Al_2O_3, standard footprint.



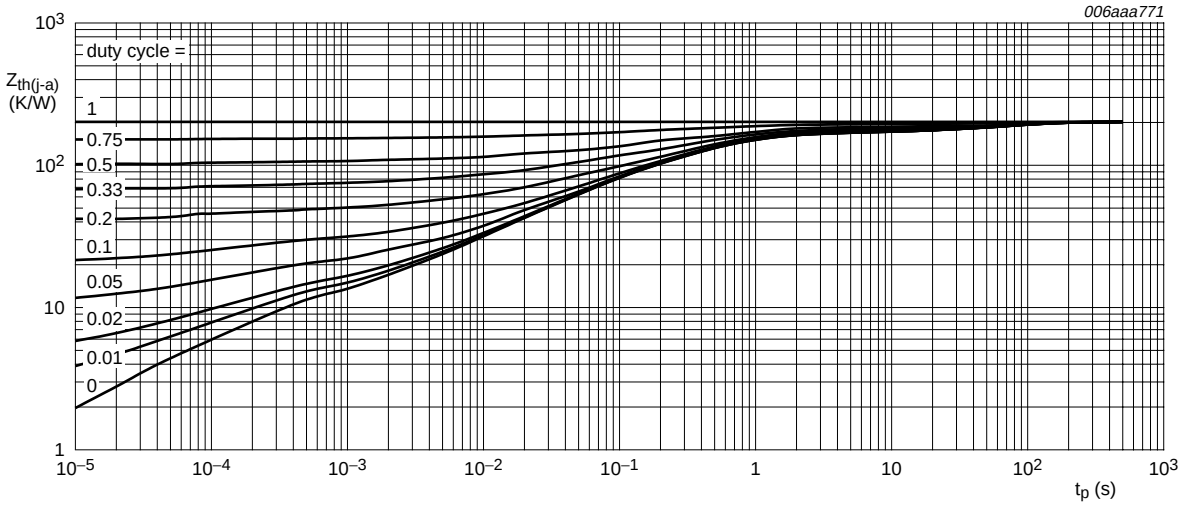
FR4 PCB, standard footprint

Fig 2. Transient thermal impedance from junction to ambient as a function of pulse duration; typical values



FR4 PCB, mounting pad for collector 1cm^2

Fig 3. Transient thermal impedance from junction to ambient as a function of pulse duration; typical values



Ceramic PCB, Al_2O_3, standard footprint

Fig 4. Transient thermal impedance from junction to ambient as a function of pulse duration; typical values

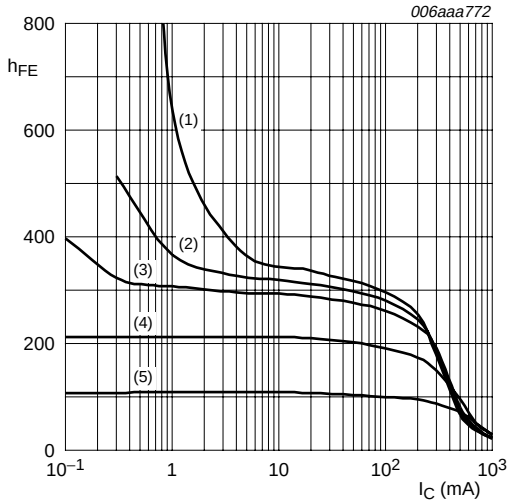
7. Characteristics

Table 7. Characteristics

T_{amb} = 25 °C unless otherwise specified

Symbol	Parameter	Conditions		Min	Typ	Max	Unit
Per NPN transistor							
I_{CBO}	collector-base cut-off current	V_{CB} = 40 V; I_E = 0 A		-	-	10	nA
		V_{CB} = 40 V; I_E = 0 A; T_j = 150 °C		-	-	10	µA
h_{FE}	DC current gain	V_{CE} = 5 V; I_C = 1 mA		100	210	-	
		V_{CE} = 5 V; I_C = 200 mA		100	170	300	
		V_{CE} = 5 V; I_C = 500 mA	[1]	50	100	-	
V_{CEsat}	collector-emitter saturation voltage	I_C = 200 mA; I_B = 20 mA		-	150	250	mV
		I_C = 500 mA; I_B = 50 mA	[1]	-	300	500	mV
V_{BEsat}	base-emitter saturation voltage	I_C = 200 mA; I_B = 20 mA		-	0.86	1	V
		I_C = 500 mA; I_B = 50 mA	[1]	-	0.95	1.1	V
Per PNP transistor							
I_{CBO}	collector-base cut-off current	V_{CB} = –40 V; I_E = 0 A		-	-	–10	nA
		V_{CB} = –40 V; I_E = 0 A; T_j = 150 °C		-	-	–10	µA
h_{FE}	DC current gain	V_{CE} = –5 V; I_C = –1 mA		100	180	-	
		V_{CE} = –5 V; I_C = –200 mA		80	125	300	
		V_{CE} = –5 V; I_C = –500 mA	[1]	50	80	-	
V_{CEsat}	collector-emitter saturation voltage	I_C = –200 mA; I_B = –20 mA		-	–130	–250	mV
		I_C = –500 mA; I_B = –50 mA	[1]	-	–280	–500	mV
V_{BEsat}	base-emitter saturation voltage	I_C = –200 mA; I_B = –20 mA		-	–0.87	–1	V
		I_C = –500 mA; I_B = –50 mA	[1]	-	–0.98	–1.1	V
Per device							
t_d	delay time	I_C = 0.15 A; V_I = 7.5 V		-	3	-	ns
t_r	rise time			-	3	-	ns
t_{on}	turn-on time			-	6	-	ns
t_s	storage time			-	2	-	ns
t_f	fall time			-	3	-	ns
t_{off}	turn-off time			-	5	-	ns

[1] Pulse test: $t_p \leq 300$ µs; $\delta \leq 0.02$



V_{CE} = 5 V

(1) T_{amb} = 150 °C

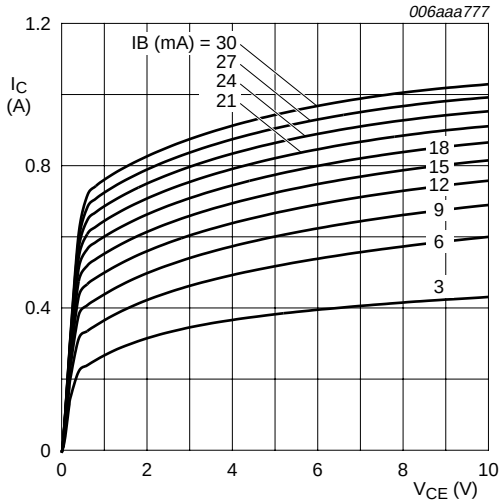
(2) T_{amb} = 125 °C

(3) T_{amb} = 100 °C

(4) T_{amb} = 25 °C

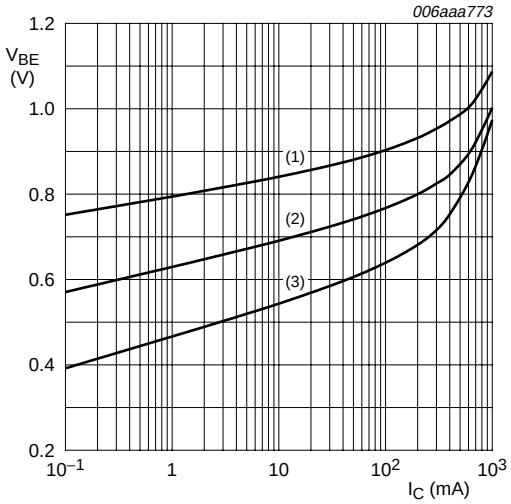
(5) T_{amb} = −55 °C

Fig 5. TR1 (NPN): DC current gain as a function of collector current; typical values



T_{amb} = 25 °C

Fig 6. TR1 (NPN): Collector current as a function of collector-emitter voltage; typical values



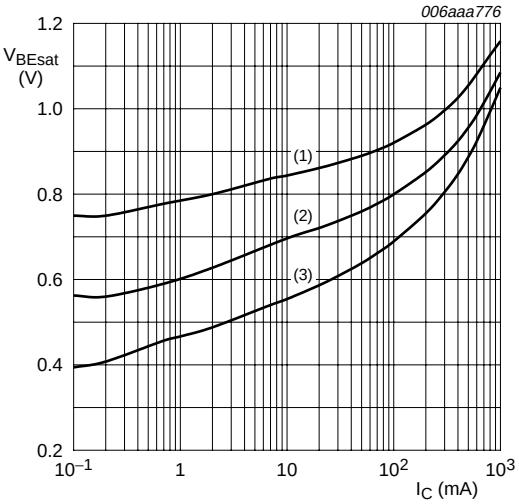
V_{CE} = 5 V

(1) T_{amb} = −55 °C

(2) T_{amb} = 25 °C

(3) T_{amb} = 100 °C

Fig 7. TR1 (NPN): Base-emitter voltage as a function of collector current; typical values



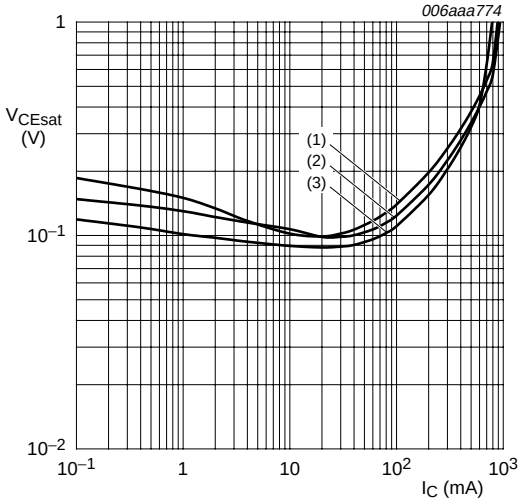
I_C/I_B = 20

(1) T_{amb} = −55 °C

(2) T_{amb} = 25 °C

(3) T_{amb} = 100 °C

Fig 8. TR1 (NPN): Base-emitter saturation voltage as a function of collector current; typical values



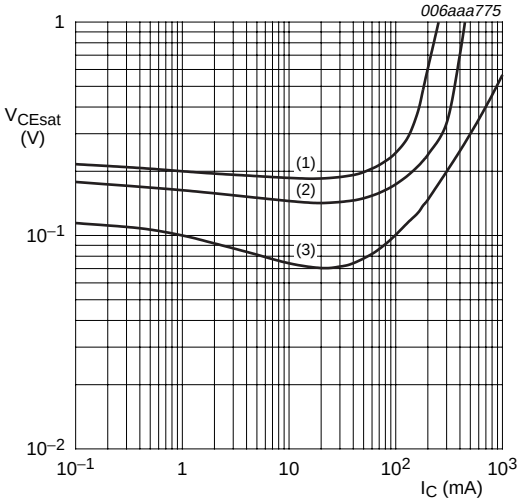
I_C/I_B = 20

(1) T_{amb} = 100 °C

(2) T_{amb} = 25 °C

(3) T_{amb} = −55 °C

Fig 9. TR1 (NPN): Collector-emitter saturation voltage as a function of collector current; typical values



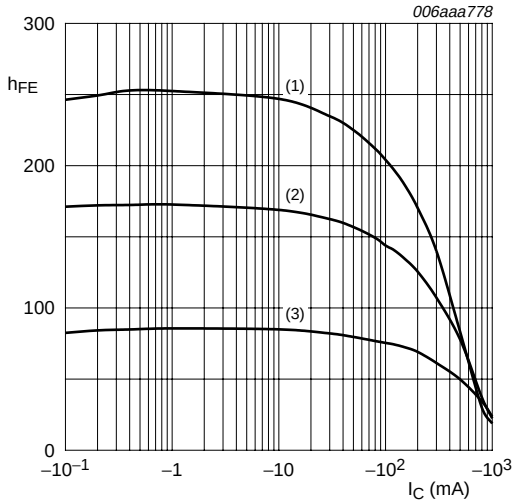
T_{amb} = 25 °C

(1) I_C/I_B = 100

(2) I_C/I_B = 50

(3) I_C/I_B = 10

Fig 10. TR1 (NPN): Collector-emitter saturation voltage as a function of collector current; typical values



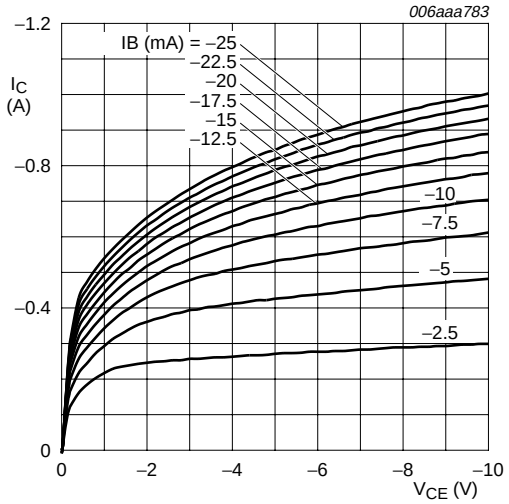
V_{CE} = −5 V

(1) T_{amb} = 100 °C

(2) T_{amb} = 25 °C

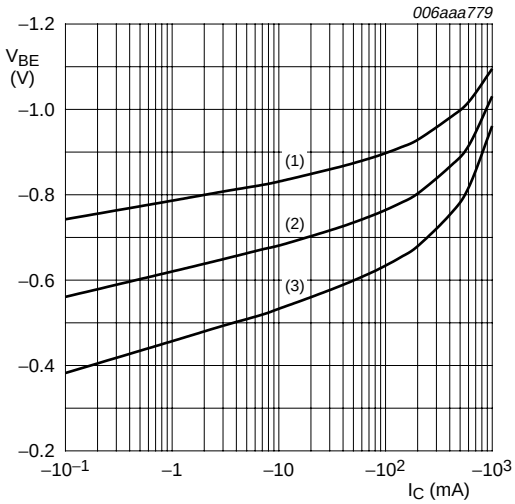
(3) T_{amb} = −55 °C

Fig 11. TR2 (PNP): DC current gain as a function of collector current; typical values



T_{amb} = 25 °C

Fig 12. TR2 (PNP): Collector current as a function of collector-emitter voltage; typical values



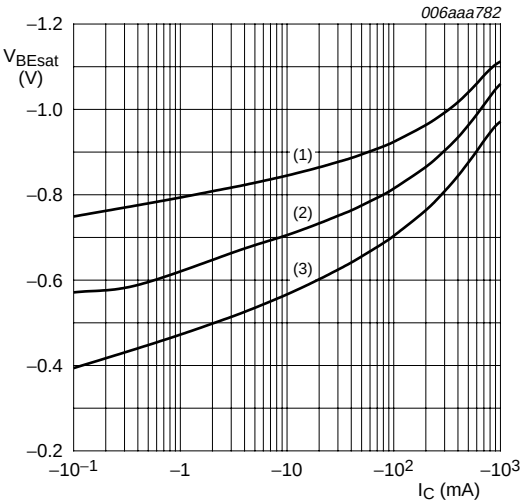
V_{CE} = −5 V

(1) T_{amb} = −55 °C

(2) T_{amb} = 25 °C

(3) T_{amb} = 100 °C

Fig 13. TR2 (PNP): Base-emitter voltage as a function of collector current; typical values



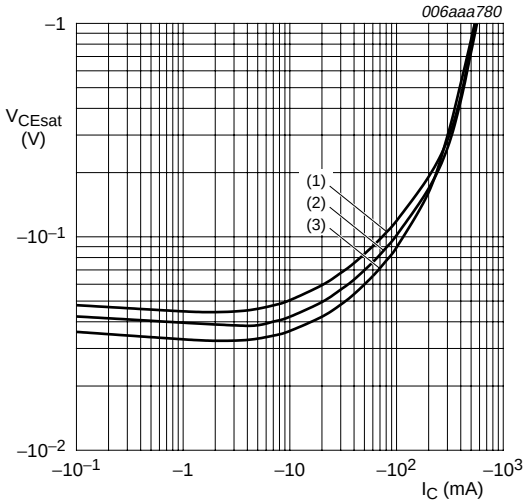
I_C/I_B = 20

(1) T_{amb} = −55 °C

(2) T_{amb} = 25 °C

(3) T_{amb} = 100 °C

Fig 14. TR2 (PNP): Base-emitter saturation voltage as a function of collector current; typical values



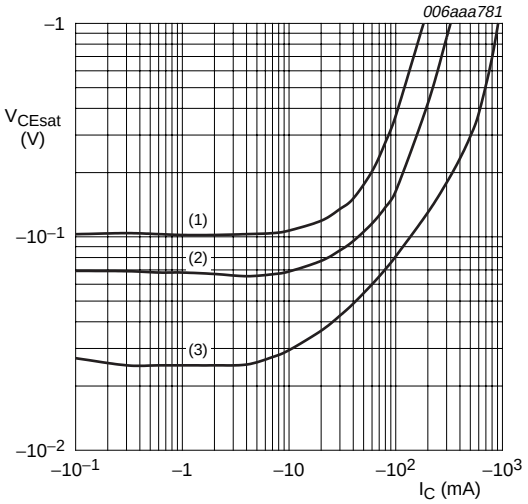
I_C/I_B = 20

(1) T_{amb} = 100 °C

(2) T_{amb} = 25 °C

(3) T_{amb} = −55 °C

Fig 15. TR2 (PNP): Collector-emitter saturation voltage as a function of collector current; typical values



T_{amb} = 25 °C

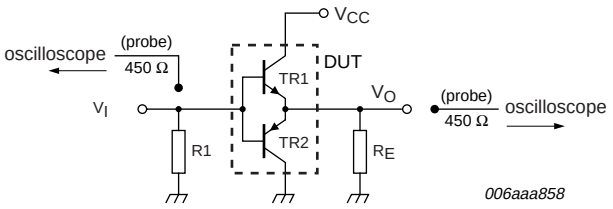
(1) I_C/I_B = 100

(2) I_C/I_B = 50

(3) I_C/I_B = 10

Fig 16. TR2 (PNP): Collector-emitter saturation voltage as a function of collector current; typical values

8. Test information



I_C = 0.15 A; V_I = 7.5 V; R1 = 56 Ω; R_E = 47 Ω

Fig 17. Test circuit for switching times

9. Package outline

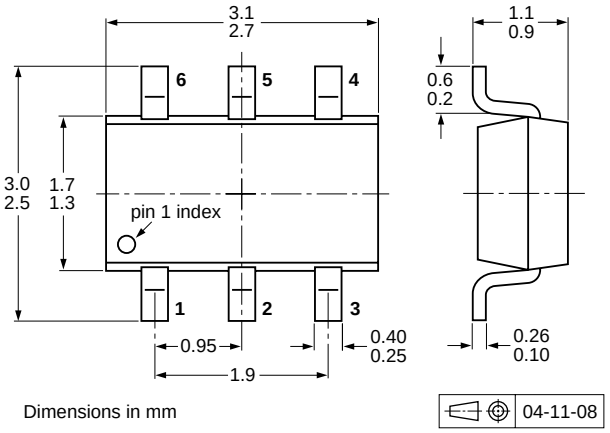


Fig 18. Package outline SOT457 (SC-74)

10. Packing information

Table 8. Packing methods

The indicated -xxx are the last three digits of the 12NC ordering code.[1]

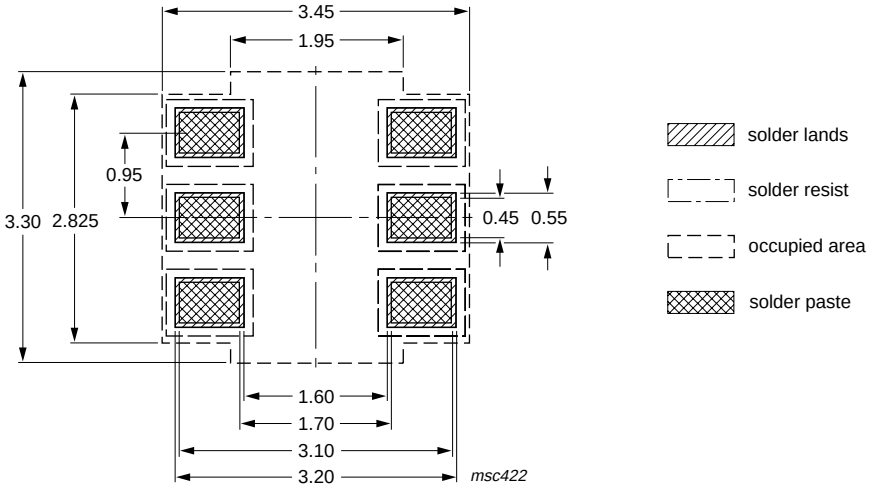
Type number	Package	Description		Packing quantity	
				3000	10000
PMD2001D	SOT457	4 mm pitch, 8 mm tape and reel; T1	[2]	-115	-135
		4 mm pitch, 8 mm tape and reel; T2	[3]	-125	-165

[1] For further information and the availability of packing methods, see Section 14.

[2] T1: normal taping

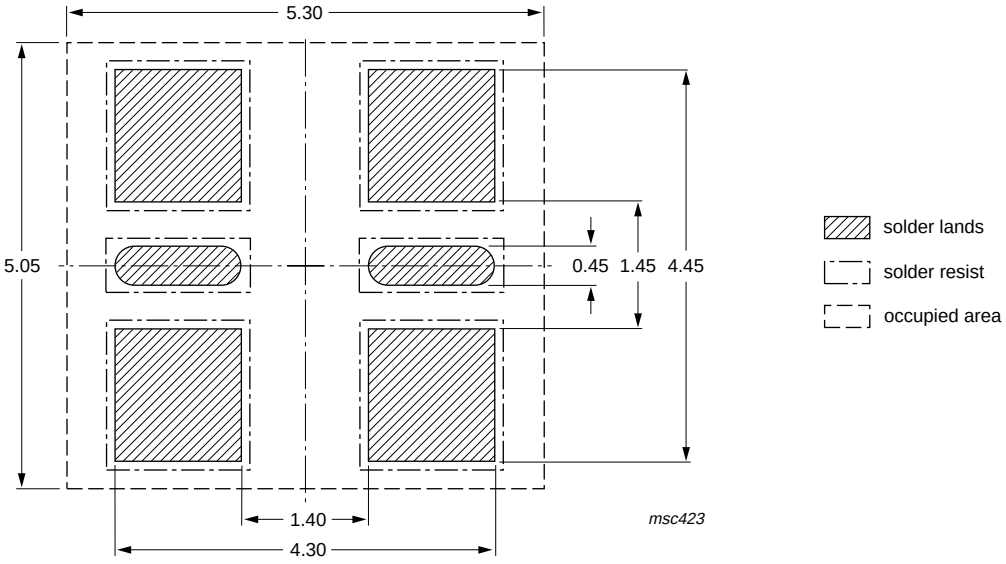
[3] T2: reverse taping

11. Soldering



Dimensions in mm

Fig 19. Reflow soldering footprint SOT457 (SC-74)



Dimensions in mm

Fig 20. Wave soldering footprint SOT457 (SC-74)

12. Revision history

Table 9. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes
PMD2001D_2	20090828	Product data sheet	-	PMD2001D_1
Modifications:	• This data sheet was changed to reflect the new company name NXP Semiconductors, including new legal definitions and disclaimers. No changes were made to the technical content. • Figure 20 “Wave soldering footprint SOT457 (SC-74)”: updated			
PMD2001D_1	20060925	Product data sheet	-	-

13. Legal information

13.1 Data sheet status

Document status[1][2]	Product status[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

[1] Please consult the most recently issued document before initiating or completing a design.

[2] The term 'short data sheet' is explained in section "Definitions".

[3] The product status of device(s) described in this document may have changed since this document was published and may differ in case of multiple devices. The latest product status information is available on the Internet at URL http://www.nxp.com.

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15. Contents

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Date of release: 28 August 2009
Document identifier: PMD2001D_2

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